






TEST REPORT

Eurofins KCTL Co.,Ltd. 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea Tel: 82-70-5008-1021 Fax: 82-505-299-8311 www.kctl.co.kr	Report No.: KR23-SEF0190 Page (1) of (21)	 KCTL
<p>1. Client</p> <ul style="list-style-type: none"> ◦ Name : Samsung Electronics Co., Ltd. ◦ Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea ◦ Date of Receipt : 2023-08-24 <p>2. Use of Report : -</p> <p>3. Name of Product / Model : Tablet PC / SM-X306B</p> <p>4. Manufacturer / Country of Origin : Samsung Electronics Co., Ltd. / Vietnam</p> <p>5. Date of Test : 2023-10-25</p> <p>6. Location of Test : <input checked="" type="checkbox"/> Permanent Testing Lab <input type="checkbox"/> On Site Testing (Address: 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea)</p> <p>7. Test method used : ANSI C63.4:2014, Class B FCC Part 15 Subpart B</p> <p>8. FCC ID : A3LSMX306B</p> <p>9. Test Results : Refer to the test result in the test report</p>		
Affirmation	Tested by  Name : Dootae Lee (Signature)	Technical Manager  Name : Moonseop Cho (Signature)
2023-11-03		
Eurofins KCTL Co.,Ltd.		
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REPORT REVISION HISTORY

Date	Revision	Page No
2023-11-03	Originally issued	-

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General remarks for test reports

Statement concerning the uncertainty of the measurement systems used for the tests

(may be required by the product standard or client)

Internal procedure used for type testing through which traceability of the measuring uncertainty has been established:


Procedure number, issue date and title:

Calculations leading to the reported values are on file with the testing laboratory that conducted the testing.

Statement not required by the standard or client used for type testing

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<p>Eurofins KCTL Co.,Ltd. 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea Tel: 82-70-5008-1021 Fax: 82-505-299-8311 www.kctl.co.kr</p>	<p>Report No.: KR23-SEF0190 Page (4) of (21)</p>	<p> KCTL</p>
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1. Applicant information

Applicant: Samsung Electronics Co., Ltd.
Address: 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do,
16677, Rep. of Korea

Manufacturer: Samsung Electronics Co., Ltd.
Address: 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do,
16677, Rep. of Korea

Factory: Samsung Electronics Vietnam Thai Nguyen Co., Ltd
Address: Yen Binh Industrial Park, Dong Tien Ward, Pho Yen Town,
Thai Nguyen Province, Vietnam

2. Laboratory information

Address

Eurofins KCTL Co.,Ltd. (Suwon Lab.)

65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea

Telephone Number: 82 70 5008 1021

Facsimile Number: 82 505 299 8311

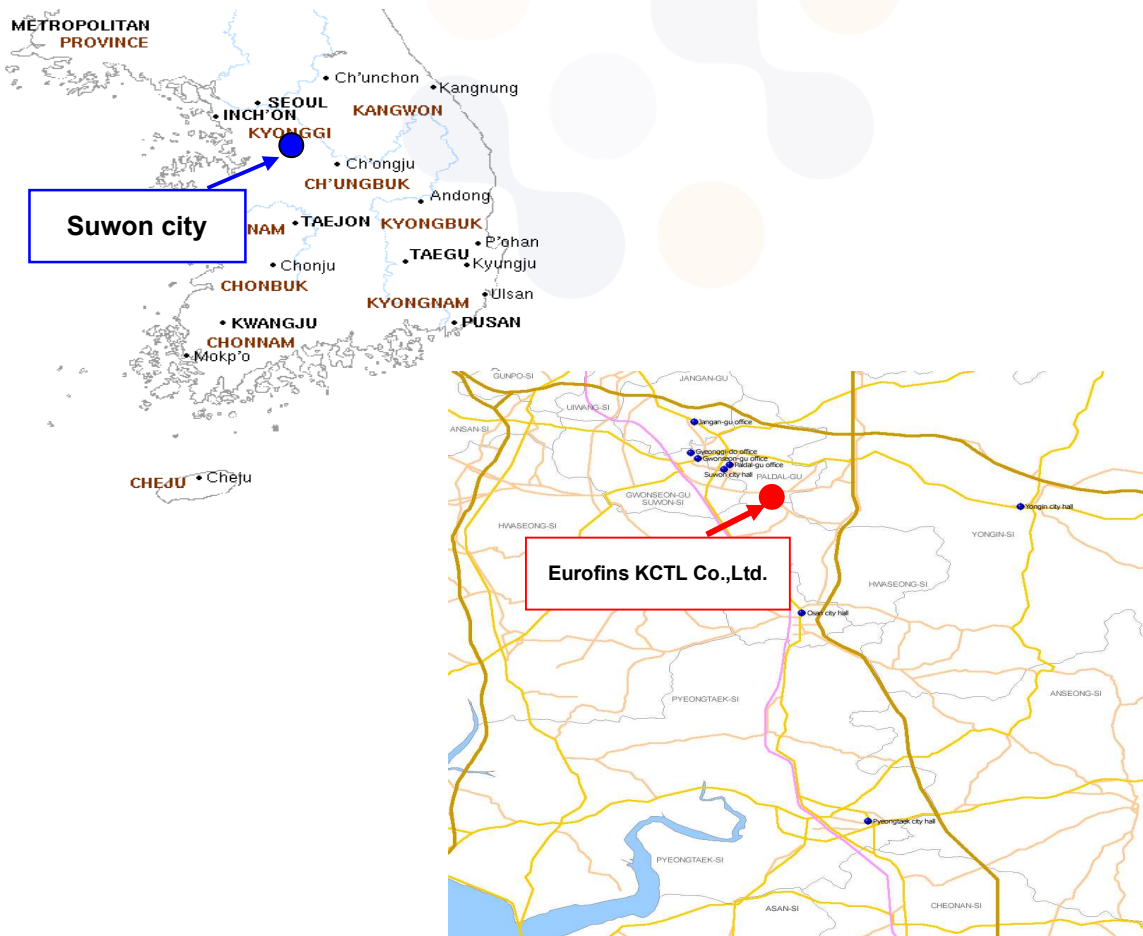
FCC Site Designation No: KR0040

VCCI Registration No.: R-20080, G-20078, C-20059, T-20056

Industry Canada Registration No. : 8035A

KOLAS NO.: KT231

SITE MAP



3. Test system configuration

3.1 Operation environment

	Temperature	Humidity	Pressure
Chamber 10 m (RE)	24.7 °C / 24.4 °C	36.4 % R.H. / 36.7 % R.H.	-
Shielded room(CE)	24.4 °C	36.7 % R.H.	-

Test site

These testing items were performed following locations;

Test item	Test site
Conducted Emission	Shielded Room
Radiated Emission	10 m Chamber

3.2 Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC.

The factors contributing to uncertainties are test receiver, cable loss, antenna factor calibration, Antenna directivity, antenna factor variation with height, antenna phase center variation, antenna frequency interpolation, measurement distance variation, site imperfection, mismatch, and system repeatability. Based on CISPR 16-4-2, the measurement uncertainty level with a 95 % confidence level was applied.

Conducted Emission measurement (Confidence level about 95 %, $k = 2$)			
Shielded Room (CE#1)	9 kHz ~ 150 kHz:	3.58 dB	
	150 kHz ~ 30 MHz:	3.16 dB	
Shielded Room (CE#2)	9 kHz ~ 150 kHz:	3.58 dB	
	150 kHz ~ 30 MHz:	3.16 dB	
Radiated Emission measurement (Confidence level about 95 %, $k = 2$)			
10 m Chamber (4F)	30 MHz ~ 300 MHz	3 m:	4.96 dB
		10 m:	4.96 dB
	300 MHz ~ 1 000 MHz	3 m:	4.08 dB
		10 m:	4.06 dB
	1 GHz ~ 6 GHz	3 m:	5.52 dB
	6 GHz ~ 18 GHz	3 m:	6.18 dB
	18 GHz ~ 30 GHz	3 m:	5.00 dB
30 GHz ~ 40 GHz	3 m:	4.50 dB	
10 m Chamber (2F)	30 MHz ~ 300 MHz	3 m:	4.50 dB
		10 m:	4.50 dB
	300 MHz ~ 1 000 MHz	3 m:	3.50 dB
		10 m:	3.48 dB
1 GHz ~ 6 GHz	3 m:	5.04 dB	
6 GHz ~ 18 GHz	3 m:	6.10 dB	

3.3 Measurement Program

These test items were performed by software programs;

Test item	Measurement Program		Used
Conducted Emission	EP5/CE_Ver 5.4.0(TOYO)		☒
Radiated Emission	2F	EP10/RE_Ver 2021.01.000 (TOYO)	☒
	4F	EP5/RE_Ver 5.11.10(TOYO)	



4. Description of EUT

4.1 General information

Declared Hardware Version	REV1.0
Declared Software Version	X306B.001



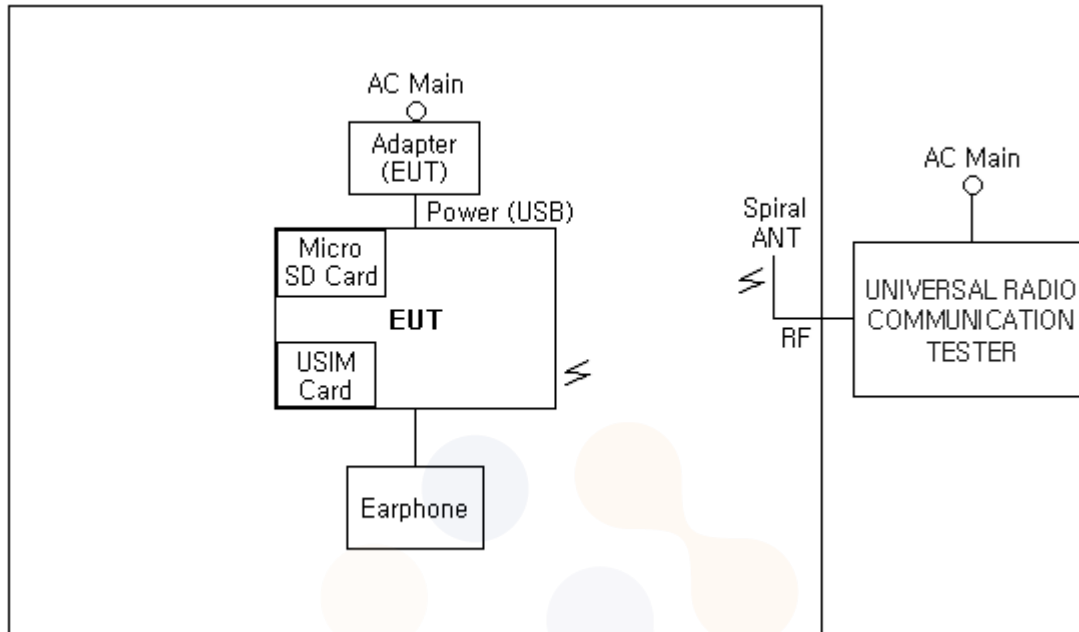
4.2 Product description

Type of product	Tablet PC
Model name (Basic)	SM-X306B
Model name (Variant)	-
Difference	-
Serial no	-
Testing voltage	120 V, 60 Hz
Input/Output rating	Adapter (EP-TA200) Input: AC 100 V - 240 V, 50-60 Hz, 0.5 A Output: DC 9.0 V, 1.67 A or DC 5.0 V, 2.0 A
Internal clock frequency	Above 108 MHz
RF Frequency	LTE Band 2: 1 850.7 MHz ~ 1 909.3 MHz LTE Band 4: 1 710.7 MHz ~ 1 754.3 MHz LTE Band 5: 824.7 MHz ~ 848.3 MHz LTE Band 12: 699.7 MHz ~ 715.3 MHz LTE Band 13: 779.5 MHz ~ 784.5 MHz LTE Band 17: 706.5 MHz ~ 713.5 MHz LTE Band 26: 824.7 MHz ~ 848.3 MHz LTE Band 41: 2 498.5 MHz ~ 2 687.5 MHz LTE Band 66: 1 710.7 MHz ~ 1 779.3 MHz GSM 850: 824.2 MHz ~ 848.8 MHz GSM 1900: 1 850.2 MHz ~ 1 909.8 MHz WCDMA 850: 826.4 MHz ~ 846.6 MHz WCDMA 1700: 1 712.4 MHz ~ 1 752.6 MHz WCDMA 1900: 1 852.4 MHz ~ 1 907.6 MHz NR Band 5: 826.5 MHz ~ 846.5 MHz NR Band 66: 1 712.5 MHz ~ 1 777.5 MHz
Note	-The following accessories were provided by the manufacturer. 1) Adapter (EP-TA200 / SAMSUNG) 2) USB Cable

4.3 Auxiliary equipments

Type	Model / Part #	S/N	Manufacturer	SDoC & FCC ID
USIM Card	-	-	-	-
Micro SD Card (64 GB)	Samsung EVO Plus MB-MB64G	-	SAMSUNG	-
UNIVERSAL RADIO COMMUNICATION TESTER	CMU200	-	R&S	-
Spiral ANT	-	-	-	-

4.4 Test configuration



	Start		End		Cable	
	Name	I/O port	Name	I/O port	Length (m)	Spec.
1	EUT	Power (USB)	Adapter (EUT)	-	1.0	Unshield
2		USIM	USIM Card	-	Direct	-
3		Micro SD	Micro SD Card	-	Direct	-
4		Earphone	Earphone	-	1.5	Unshield
5	Adapter (EUT)	Power	AC Main	-	Direct	-
6	UNIVERSAL RADIO COMMUNICATION TESTER	RF	Spiral ANT	-	2.0	Shield

4.5 Operating conditions

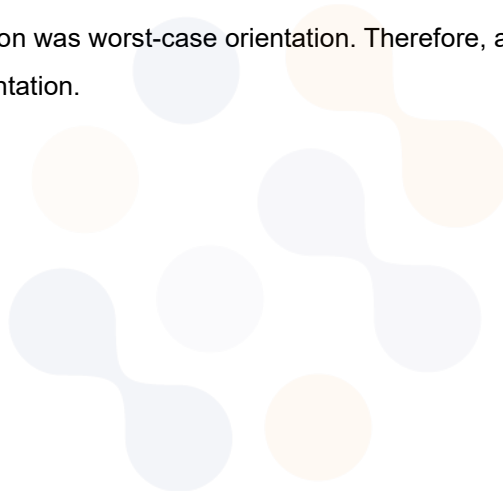
The EUT was configured as normal intended use.

Test mode	Normal operating
Test #1	Charging(w/TA) + Cellular receiver (GSM850_Mid channel)

Note 1. All cellular RX bands operating below 950 MHz, including GSM, WCDMA and LTE, 5G NR have been investigated with low/middle/high channels. Among the bands, GSM850_Mid channel is the worst mode.

Note 2. It means this device needs to be tested with 3 orientations (x, y and z) and at least the worst case orientation shall be set for final test.

It was determined that Z orientation was worst-case orientation. Therefore, all final radiated testing was performed with the EUT in Z orientation.



5. Summary of test results

5.1 Summary of EMI emission test results

Applied	Test items	Test method	Result
☒	Conducted Emission	ANSI C63.4:2014, Class B FCC Part 15 Subpart B	Pass
☒	Radiated Emission	ANSI C63.4:2014, Class B FCC Part 15 Subpart B	Pass



6. Test results

6.1 Conducted Emissions

Testing voltage	120 V, 60 Hz		
Test facility	Shielded room (CE#2)		
Date	2023-10-25		
Temperature (°C)	24.4 °C	Humidity (% R.H.)	36.7 % R.H.
Remarks	Pass		

6.1.1 Limits of conducted emissions measurement

Frequency [MHz]	Class A (dB(μ V))		Class B (dB(μ V))	
	Quasi-peak	Average	Quasi-peak	Average
0.15 ~ 0.5	79	66	66 ~ 56 ¹⁾	56 ~ 46 ¹⁾
0.5 ~ 5	73	60	56	46
5 ~ 30	73	60	60	50

¹⁾ The limit decreases linearly with the logarithm of frequency

6.1.2 Measurement procedure

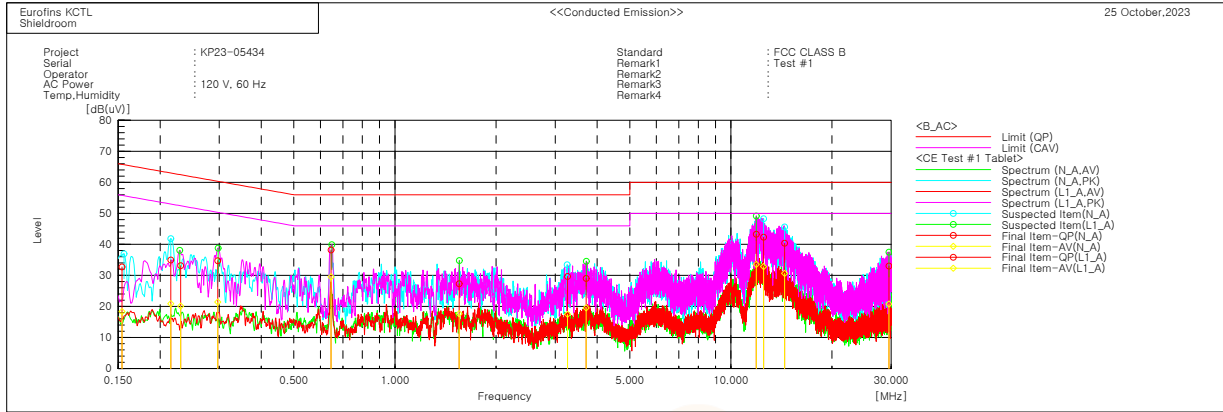
The measurements were performed in a shielded room. EUT was setup as shown in photograph and placed on a non-metallic table height of 0.8 m above the reference ground plane. The rear of table was located 0.4 m to the vertical conducted plane. EUT was power through the LISN, which was bonded to the ground plane. The LISN power was filtered. Each EUT power lead, except ground (safety) lead was individually connected through a LISN to input power source. EUT signal cables that hung closer than 0.4 m to the Horizontal metal ground 0.3 m ~ 0.4 m long. The power cord was bundles in the center. All peripheral equipment was powered from a sub LISN. The LISN and ISN were positioned 0.8 m from the EUT. Peak and Average detection were used in preliminary testing and Quasi-peak and Average detections were used at final measurement.

6.1.3 Used equipments

Equipment	Model no.	Serial no.	Makers	Next Cal. Date	Used
EMI TEST RECEIVER	ESCI 3	101428	R&S	2024.08.18	<input checked="" type="checkbox"/>
TWO-LINE V-NETWORK	ENV216	101584	R&S	2024.03.28	<input checked="" type="checkbox"/>
TWO-LINE V-NETWORK	NNLK8121	8121-472	SCHWARZBECK	2024.08.18	<input type="checkbox"/>

6.1.4 Conducted emissions measurement result

AC Main



Final Result

--- N_A Phase ---										
No.	Frequency [MHz]	Reading QP [dB(uV)]	Reading CAV [dB(uV)]	c.f [dB]	Result QP [dB(uV)]	Result CAV [dB(uV)]	Limit QP [dB(uV)]	Limit AV [dB(uV)]	Margin QP [dB]	Margin CAV [dB]
1	0.15392	22.6	8.3	10.1	32.7	18.4	65.8	55.8	33.1	37.4
2	0.21527	24.9	10.8	10.1	35.0	20.9	63.0	53.0	28.0	32.1
3	3.26237	19.6	7.4	10.1	29.7	17.5	56.0	46.0	26.3	28.5
4	12.51334	31.5	22.0	10.8	42.3	32.8	60.0	50.0	17.7	17.2
5	14.44873	29.5	19.8	10.9	40.4	30.7	60.0	50.0	19.6	19.3

--- L1_A Phase ---										
No.	Frequency [MHz]	Reading QP [dB(uV)]	Reading CAV [dB(uV)]	c.f [dB]	Result QP [dB(uV)]	Result CAV [dB(uV)]	Limit QP [dB(uV)]	Limit AV [dB(uV)]	Margin QP [dB]	Margin CAV [dB]
1	0.23024	23.2	10.3	9.9	33.1	20.2	62.4	52.4	29.3	32.2
2	0.29687	24.9	11.5	9.9	34.8	21.4	60.3	50.3	25.5	28.9
3	0.64503	28.1	19.5	10.1	38.2	29.6	56.0	46.0	17.8	16.4
4	1.55297	17.3	7.7	10.0	27.3	17.7	56.0	46.0	28.7	28.3
5	3.70944	19.0	9.5	10.0	29.0	19.5	56.0	46.0	27.0	26.5
6	11.90893	32.5	22.8	10.8	43.3	33.6	60.0	50.0	16.7	16.4
7	29.54092	21.9	9.7	11.1	33.0	20.8	60.0	50.0	27.0	29.2

6.2 Radiated Emission

Testing voltage		120 V, 60 Hz		
Test facility		10 m Chamber (2F)		
Test distance		3 m		
Date		2023-10-25		
30 MHz ~ 1 GHz	Temperature (°C)	24.7 °C	Humidity (% R.H.)	36.4 % R.H.
1 GHz ~ 30 GHz		24.4 °C		36.7 % R.H.
Remarks		Pass		

6.2.1 Limits of radiated emission measurement

Frequency [MHz]	Class A at 10 m QP(dB(μV/m))		Class B at 3 m QP(dB(μV/m))	
	FCC ¹⁾	ISED (ICES Issue 7)	FCC ¹⁾	ISED (ICES Issue 7)
30-88	39.1	40.0	40.0	40.0
88-216	43.5	43.5	43.5	43.5
216-230	46.4	46.4	46.0	46.0
230-960	46.4	47.0	46.0	47.0
Above 960	49.5	49.5	54.0	54.0

- ¹⁾: Alternative standard: CISPR, Pub. 22

- Test data in this section has been taken against the FCC 15.109(a) or (B) Limit as it is the most stringent limit.

By complying with more restrictive FCC 15.109 Limit compliance with the ICES-003 Issue 7 limit also demonstrated.

6.2.2 Measurement procedure

The test was done at a 10 m chamber with a quasi-peak detector. EUT was placed on a non-metallic table height of 0.8 m above the reference ground plane. Cables were folded back and forth forming a bundle 0.3 m to 0.4 m long and were hanged at a 0.4 m height to the ground plane.

Cables connected to EUT were fixed to cause maximum emission. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

6.2.3 Used equipments

Equipment	Model no.	Serial no.	Makers	Next Cal. Date	Used
EMI TEST RECEIVER	ESCI7	100732	R&S	2024.03.03	☒
Bilog Antenna	CBL 6112D	62438	TESEQ	2025.05.25	☒
AMPLIFIER	310N	284608	SONOMA	2024.08.18	☒
ATTENUATOR	8491B-6dB	MY39271082	KEYSIGHT	-	☒
Antenna Mast	MA4640/800-XP-ET	-	Innco Systems	-	☒
Turn Table	DT2000	79	Innco Systems	-	☒
DOUBLE RIDGED HORN ANTENNA	3117	00161083	ETS-LINDGREN	2024.01.27	☒
Horn Antenna	3116C	00218560	ETS-LINDGREN	2024.03.27	☒
Amplifier	JS44-18004000-33-8P	2055879	L-3 Narda-MITEQ	2024.03.28	☒
PXA SIGNAL ANALYZER	N9030A	MY54170575	KEYSIGHT	2024.03.17	☒
AMPLIFIER	BBV9718C	00138	SCHWARZBECK	2024.10.13	☒

6.2.4 Sample calculation

The field strength is calculated adding the antenna Factor, cable loss and, Antenna pad adding, subtracting the amplifier gain from the measured reading.

The sample calculation is as follow:

$$\text{Result} = \text{M.R} + \text{C.F}(\text{A.F} + \text{C.L} + 6 \text{ dB Att} - \text{A.G})$$

M.R = Meter Reading

C.F = Correction Factor

A.F = Antenna Factor

C.L = Cable Loss

A.G = Amplifier Gain

6 dB Att = 6 dB Attenuator

If M.R is 30 dB, A.F 12 dB, C.L 5 dB, 6 dB, A.G 35 dB

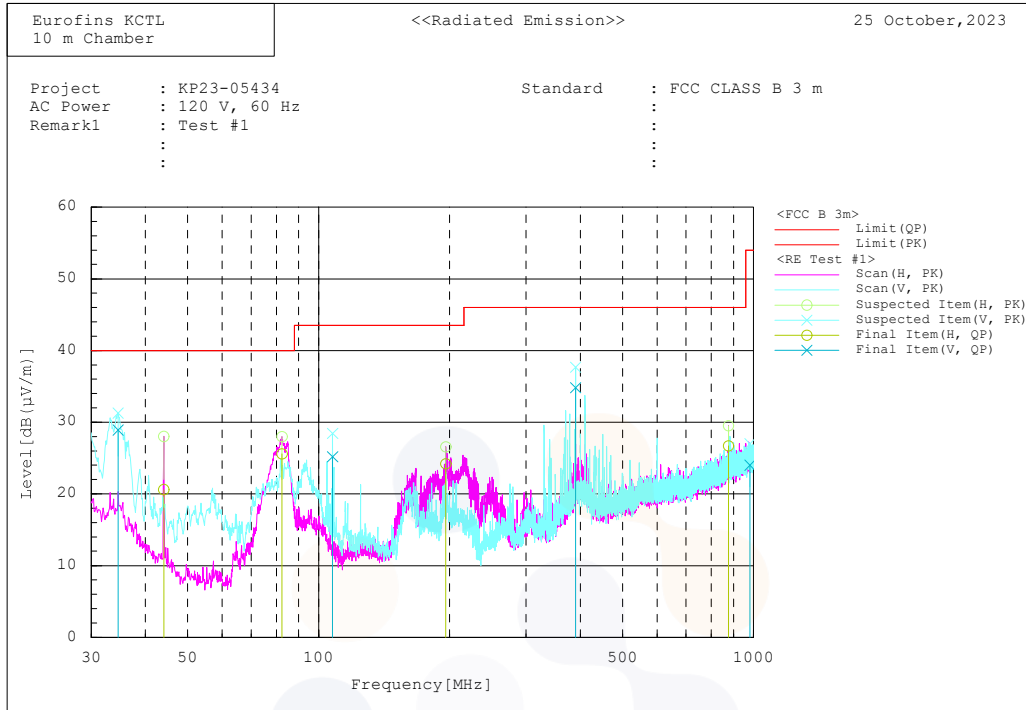
The result is $30 + 12 + 5 + 6 - 35 = 18 \text{ dB } (\mu\text{V/m})$

Bilog Antenna and ATTENUATOR (6 dB) were calibrated together.

AV = CAV : Abbreviation of CISPR Average

6.2.5 Radiated emission measurement result

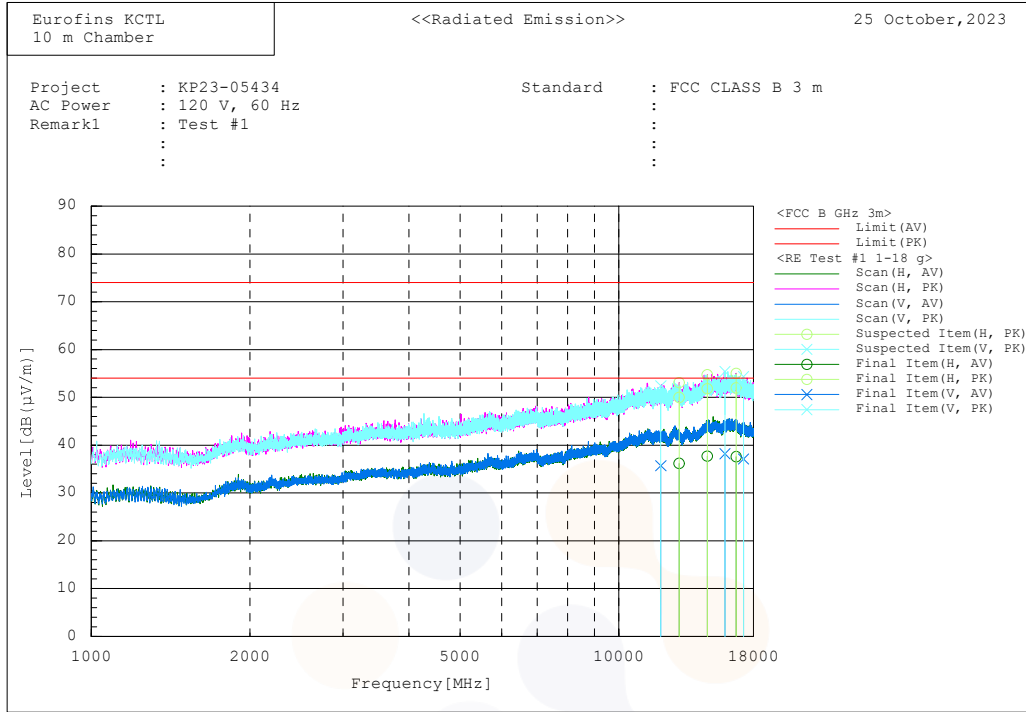
30 MHz ~ 1 GHz



Final Result

Frequency	Pol.	Reading	Factor	Level	Limit	Margin	Height	Angle
Mhz		dB(µV)	dB(1/m)	dB(µV/m)	dB(µV/m)	dB	cm	deg
		QP		QP	QP	QP		
34.608	V	37.4	-8.5	28.9	40.0	11.1	193.0	204.0
44.065	H	34.2	-13.6	20.6	40.0	19.4	122.0	234.0
82.380	H	42.2	-16.6	25.6	40.0	14.4	239.0	188.0
107.721	V	37.0	-11.8	25.2	43.5	18.3	101.0	4.0
196.113	H	37.1	-12.9	24.2	43.5	19.3	398.0	257.0
389.991	V	39.3	-4.5	34.8	46.0	11.2	174.0	257.0
875.961	H	21.1	5.6	26.7	46.0	19.3	308.0	111.0
982.419	V	16.1	7.9	24.0	54.0	30.0	106.0	224.0

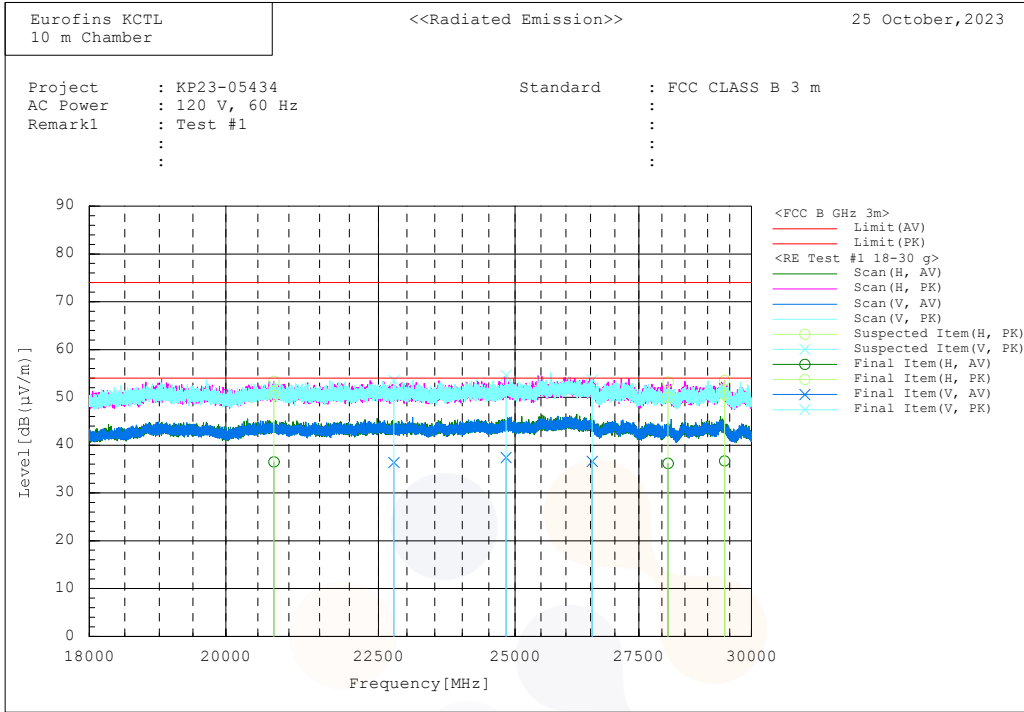
1 GHz ~ 18 GHz



Final Result

Frequency MHz	Pol.	Reading		Factor	Level		Limit		Margin		Height cm	Angle deg
		dB(µV)			dB(µV/m)		dB(µV/m)		dB			
		AV	PK		dB(1/m)		AV	PK	AV	PK		
12010.042	V	20.1	33.8	15.6	35.7	49.4	54.0	74.0	18.3	24.6	204.0	311.0
13014.750	H	19.9	33.7	16.3	36.2	50.0	54.0	74.0	17.8	24.0	398.0	324.0
14715.605	H	20.6	34.7	17.1	37.7	51.8	54.0	74.0	16.3	22.2	331.0	274.0
15902.200	V	21.3	35.9	16.9	38.2	52.8	54.0	74.0	15.8	21.2	174.0	230.0
16697.814	H	19.1	33.5	18.5	37.6	52.0	54.0	74.0	16.4	22.0	221.0	341.0
17235.028	V	19.0	33.9	18.1	37.1	52.0	54.0	74.0	16.9	22.0	349.0	111.0

18 GHz ~ 30 GHz



Final Result

Frequency MHz	Pol.	Reading		Factor	Level		Limit		Margin		Height cm	Angle deg
		dB(µV)			dB(µV/m)		dB(µV/m)		dB			
		AV	PK		dB(1/m)		AV	PK	AV	PK		
20756.441	H	31.5	45.4	5.0	36.5	50.4	54.0	74.0	17.5	23.6	314.0	234.0
22768.876	V	29.8	43.8	6.6	36.4	50.4	54.0	74.0	17.6	23.6	198.0	74.0
24826.200	V	30.6	44.9	6.8	37.4	51.7	54.0	74.0	16.6	22.3	400.0	109.0
26534.393	V	28.7	43.0	7.9	36.6	50.9	54.0	74.0	17.4	23.1	145.0	133.0
28130.407	H	29.1	42.9	7.1	36.2	50.0	54.0	74.0	17.8	24.0	332.0	357.0
29383.182	H	29.5	43.3	7.2	36.7	50.5	54.0	74.0	17.3	23.5	174.0	264.0